

Notice of References Cited	Application/Control No. 10/730,190	Applicant(s)/Patent Under Reexamination EHIRO ET AL.	
	Examiner David Lam	Art Unit 2818	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,587,370	07-2003	Hirai, Tadahiko	365/171
	B	US-			
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	D	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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